

Alkaline-stable nickel manganese oxides with ideal band gap for solar fuels photoanodes

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X-ray diffraction

The crystal structures and phase distribution of the composition libraries were determined through X-ray diffraction (XRD) measurements with the x-ray spot size limited to a 1 mm length scale, over which the composition is constant to within approximately 1%. For the $\text{Ni}_x\text{Mn}_{1-x}\text{O}_2$ libraries, a series of measurements across the composition gradient was used to generate a structural phase map to elucidate structure-property relationships. XRD patterns were acquired with a Bruker DISCOVER D8 diffractometer with $\text{Cu K}\alpha$ radiation from a Bruker $1\mu\text{S}$ source (Bruker AXS Inc., Madison, WI). Using a 0.5 mm collimator, the effective thin film measurement area was approximately 0.5×1 mm. Diffraction images were collected using a two-dimensional VÅNTEC-500 detector and integrated into one-dimensional patterns using DIFFRAC.SUITE™ EVA software. For patterns in which multiple crystalline phases were identified, the relative phase fraction of each phase was approximated by normalizing the measured intensity of the most distinguishing peak of each phase.

Composition measurements

X-ray fluorescence (XRF) was employed to measure the composition of the thin films library. The measurements were performed on an EDAX Orbis Micro-XRF system (EDAX Inc., Mahwah, NJ) with an x-ray beam approximately 2 mm in diameter. XRF counts at a certain x-ray energy directly gives an indication of the amount of material, but to be able to get the composition in atomic percent (at.%), the composition quantification was calibrated using the energy-dispersive x-ray spectroscopy (EDS). The EDS measurements were performed using an Oxford Instruments X-Max (Oxford Instruments, Concord, MA) detector on a FEI Nova NanoSEM 450 (FEI, Hillsboro, OR) with excitation from a 12 keV electron beam and the composition quantification was obtained using a thin film model in the INCAEnergy EDS analysis software.

The XRF characterization of the libraries not only established the composition axes in Figures 1 and 2 but also provided an estimate of the metal oxide thickness. In Figure 1, the circled composition with $\text{Ni}/(\text{Ni}+\text{Mn})$ values of 0.48 and 0.69 are approximately 195 and 220 nm thick, respectively. In Figure 2, the 0.48 and 0.53 samples are approximately 131 and 129 nm thick, respectively.

Experiment Details

A photograph of the sputter deposited library, electrochemical stability data, and optical characterization of Ni_6MnO_8 are provided in Figures S1-S3. The LEDs used for PEC measurements are summarized in Table S1. All PEC measurements are performed in an under filled-type cell where the electrolyte contact area is larger than the illumination area, which for the measurements with FCN corresponds to the photocurrent values being a lower limit as the not-illuminated portion of the working electrode acts as a partial current shunt. These are all high irradiance measurements intended to

elucidate trends in photoactivity as a function of composition and phase, or as in the case of Figure S2 to rapidly assess stability. This 30 minute stability measurement included approximately 900 illumination cycles, and the total photocurrent passed was in excess of 0.3 mC cm^{-2} , which corresponds to in excess of 300 nmol cm^{-2} of fundamental charge. If either Ni or Mn was corroding by a 1 e^- process, this charge would have resulted in loss of half of the respective element from the thin film, for which there is no evidence. The lack of corrosion in PEC experiments is more directly evident by the lack of photocurrent in the measurements without a sacrificial hole acceptor, since photocorrosion processes are generally not altered by such electrolyte additives.

Both NiMnO_3 and Ni_6MnO_8 phases were identified in the recently-reported computational search of screening Manganese-based ternary oxide photoanodes.¹ Table 1 of that work shows that NiMnO_3 was determined to be non-photoactive at the OER Nernstian potential by the PEC experiments in pH 6.6, pH 10 and pH 13 electrolytes, commensurate with the present work where the redox couple or hole acceptor are necessary to obtain photoactivity (Figure 1c showing photocurrent with FCN redox couple but not in its absence, Figure 2 showing photocurrent with sulfite hole acceptor).

To more clearly elucidate the relationship between transient and quasi-steady state photocurrent for the 2 samples in Figure 2b, a zoomed in version of the last 3 illumination cycles are shown in Figure S4, where the transient and quasi-steady-state photocurrent are illustrated to show that the addition of Ni_6MnO_8 to NiMnO_3 alleviates an apparent issue with surface state population, converting more of the absorbed photons to photocurrent in steady state.

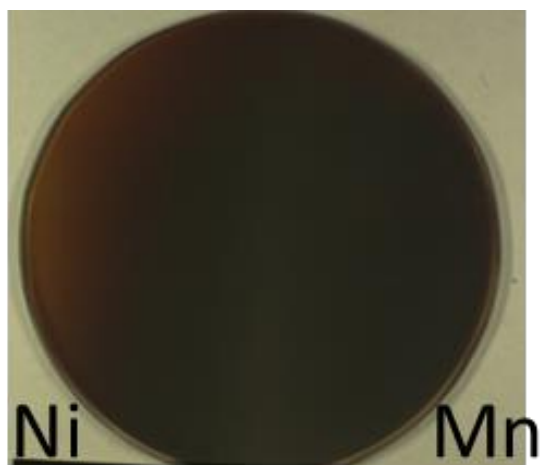


Figure S1. An image of the Ni-Mn-O library on glass substrate after annealing, demonstrating the high optical density of the thin film compositions. The elemental symbols indicate the locations of the sputtering sources.

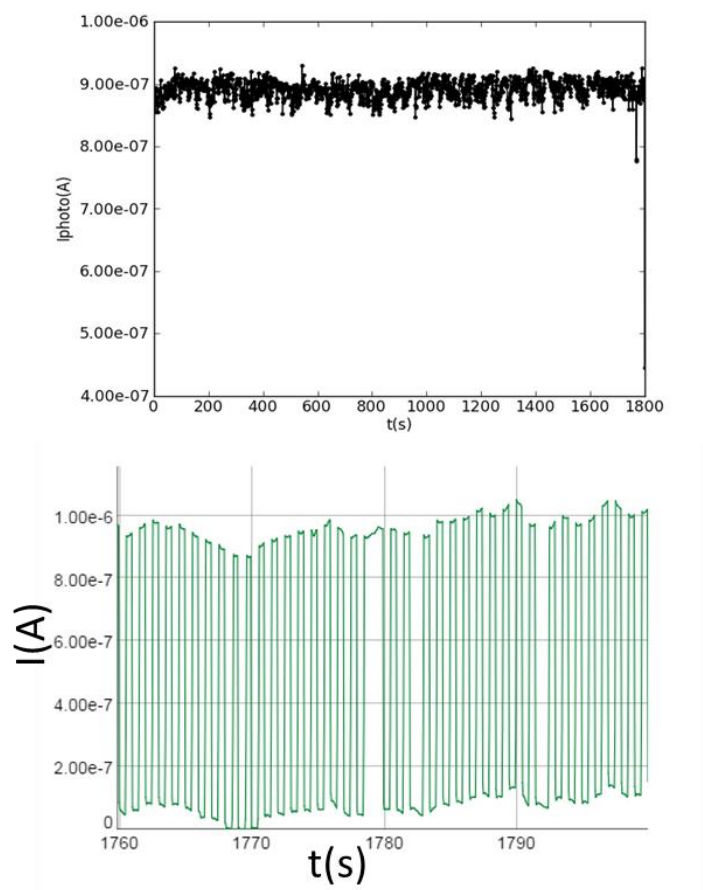


Figure S2. (top) Photocurrent with ferri/ferro cyanide (FCN) redox couple for $\text{Ni}_{0.48}\text{Mn}_{0.52}$ composition as a function of time measured over 30 minutes. (bottom) Current as a function of time for the same sample over the last 40 seconds of the 30 minute measurement, where the couple illumination cycles that appear to be a different duration are from a timing delay artifact of the instrument control software and are not impactful for the characterization of photocurrent stability.

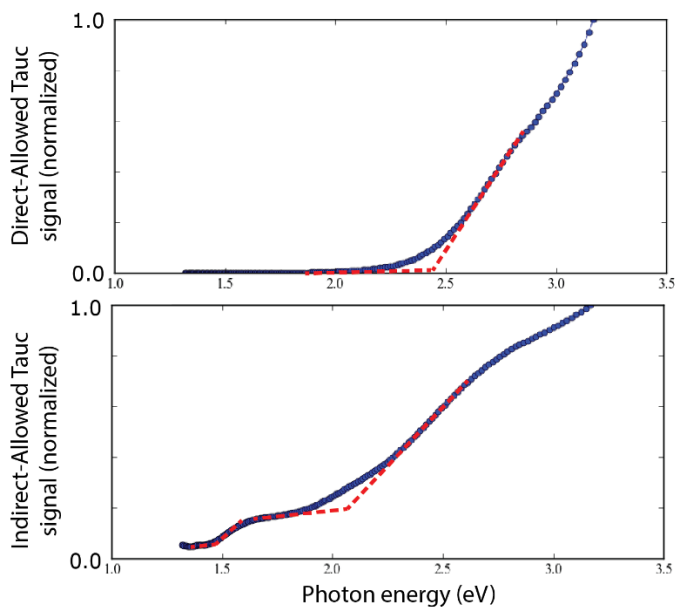


Figure S3. Tauc signals for Direct (top) and Indirect (bottom) allowed transitions for a sputter deposited 80% phase pure Ni-MnO₈ thin film. Linear models of the baseline and above-gap absorption are shown in dashed red lines, indicating a clear direct band gap at 2.4 eV and that a lower indirect gap likely exists, which could be approximately 1.5 or 2.1 eV.

Table S1: Summary of LED sources used for PEC experiments. The “front” and “back” refer to illumination from the same side as the electrolyte contact and same side as the electrical back contact, respectively.

LED Model/Geometry	Wavelength (nm)	Energy (eV)	Illum. Area (10 ⁻³ cm ²)	Irradiance (mW/cm ²)	Figures
ThorLabs M385F1/front	385 ± 5	3.22 ± 0.04	6.4	439.3	1c (<i>J_{OER}</i>)
ThorLabs M385F1/front	385 ± 5	3.22 ± 0.04	18	204.2	2b
ThorLabs M385F1/back	385 ± 5	3.22 ± 0.04	25	181.2	1b, 1c (<i>J_{FCN}</i>), 3a
ThorLabs M455F1/back	455 ± 12.5	2.72 ± 0.08	25	124.0	3a
ThorLabs M530F1/back	530 ± 16.5	2.34 ± 0.07	25	56.8	3a
ThorLabs M617F1/back	617 ± 9	2.01 ± 0.03	25	117.6	3a

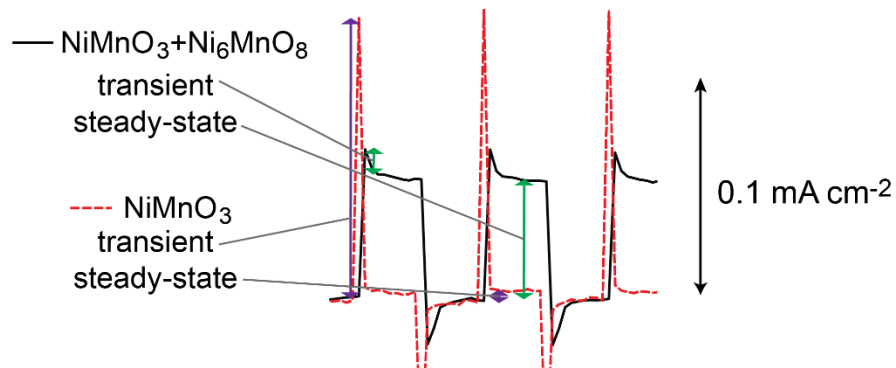


Figure S4. Zoomed-in version of Figure 2b to enable labelling of the transient and quasi-steady-state photocurrent for of NiMnO_3 (purple arrows) and $\text{NiMnO}_3 + \text{Ni}_6\text{MnO}_8$ (green arrows).

SEM imaging

Secondary Electron Microscopy (SEM) were performed with a FEI Nova NanoSEM 450 using a 15 keV electron beam for the 2 samples measured in sulfite-containing electrolyte in Figure 2. The images in Figure S5 (note the slightly different magnification and scale bars) show that the morphology is similar in both samples with apparent columnar-like morphology on the 200 nm scale. The invariance of the morphology upon addition of the Ni_6MnO_8 phase to the NiMnO_3 further corroborates the conclusion that a heterojunction gives rise to the increased steady state photocurrent.

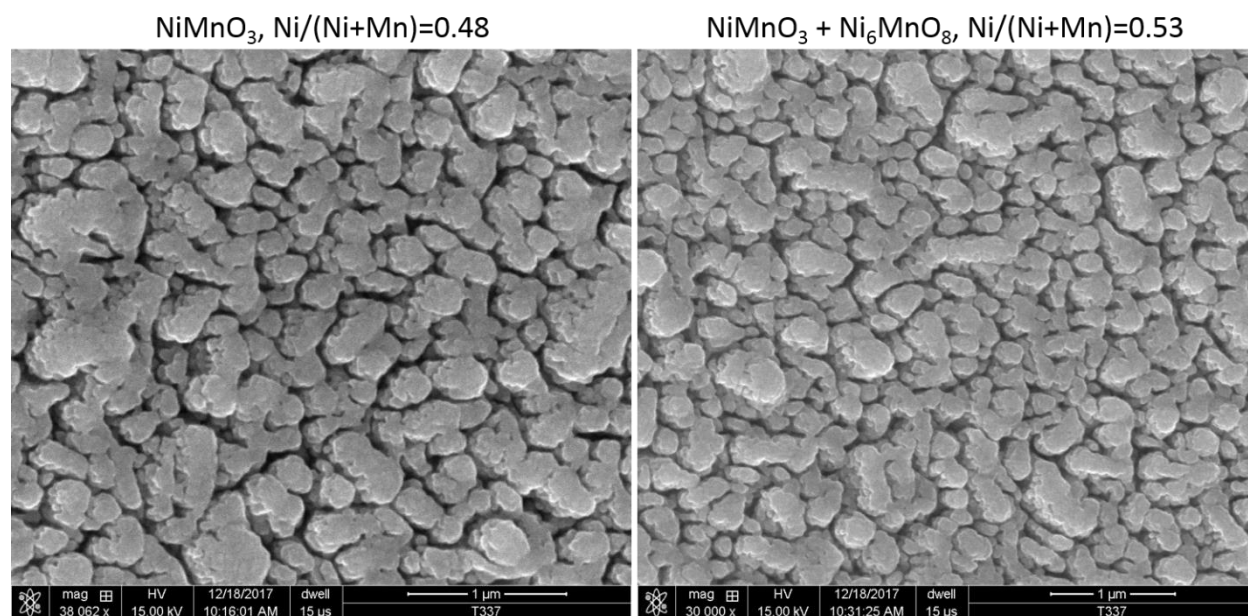


Figure S5. SEM images representative of the 2 samples in Figure 2: $\text{Ni}/(\text{Ni}+\text{Mn})$ values of 0.48 (NiMnO_3) and 0.53 ($\text{NiMnO}_3 + \text{Ni}_6\text{MnO}_8$) with approximately thickness 131 and 129 nm, respectively.

Additional electrochemical characterization

To further elucidate the properties of the Ni-Mn oxide materials we perform 2 additional types of electrochemical experiment. In pH 13 electrolyte without a hole scavenger, where the photoanodes

were found to exhibit little to no photoactivity in Figure 1, cyclic voltammetry (CV) at 0.05 V s^{-1} was performed from just below the OER Nernstian potential to approximately 0.55 V overpotential. The electrolyte contact area was approximately 0.5 cm^2 but was not precisely measured, so the CV is plotted using the current (not the current density) for representative CVs at 4 library compositions in Figure S6. Among the systematic trends with respect to composition, the most notable are the increase in both double layer capacitance and the OER electrocatalytic activity with Mn concentration. When the Mn_2O_3 phase is present, catalysis is observed below 0.5 V overpotential, but the observed electrocatalysis onset for NiMnO_3 and its phase mixture with Ni_6MnO_8 is above 0.5 V overpotential, which is commensurate with the introductory discussion of previous reports of detectable but not high activity of these materials, and with the requirement for adding a hole scavenger to attain appreciable photocurrent since the surface does not contain a suitable electrocatalyst.

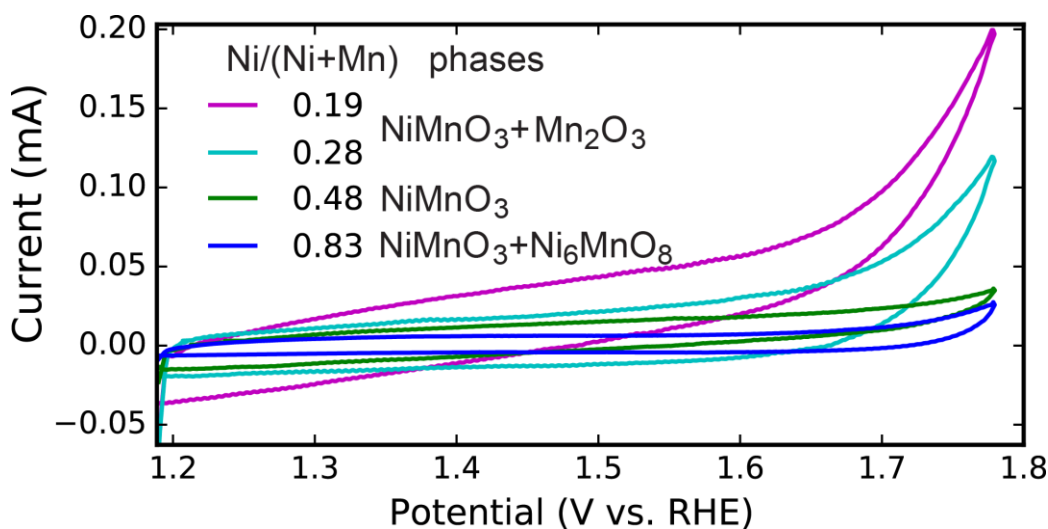


Figure S6. CVs with no illumination for select compositions in pH 13 electrolyte 0.05 V s^{-1} revealing the relative catalytic inactivity of NiMnO_3 and its phase mixture with Ni_6MnO_8 , requiring a hole scavenger to be present to attain photoactivity with 1.23 V vs RHE bias.

Due to the high absorption coefficient, thinner Ni-Mn oxide thin can still absorb sufficient light and may provide higher photocurrent depending on the limiting factors in the thicker films. To explore this possibility, a film with approximately one third the thickness (42 nm) was deposited at the $\text{Ni}_{0.64}\text{Mn}_{0.36}$ oxide composition, which as expected exhibited a mixture of NiMnO_3 and Ni_6MnO_8 . The toggled 385 nm illumination in sulfite-containing pH 13 electrolyte was performed (same conditions as Figure 2), and a linear sweep voltammetry at 0.02 V s^{-1} was used to characterize the photocurrent as a function of applied bias, as shown in Figure S7. The photocurrent at 1.23 V vs RHE is similar to that observed in the mixed-phase samples in Figure 2, indicating that the thinning of the photoanode did not improve photoactivity, suggesting that a property such as low hole transport or high recombination rate is limiting the photocurrent in these materials.

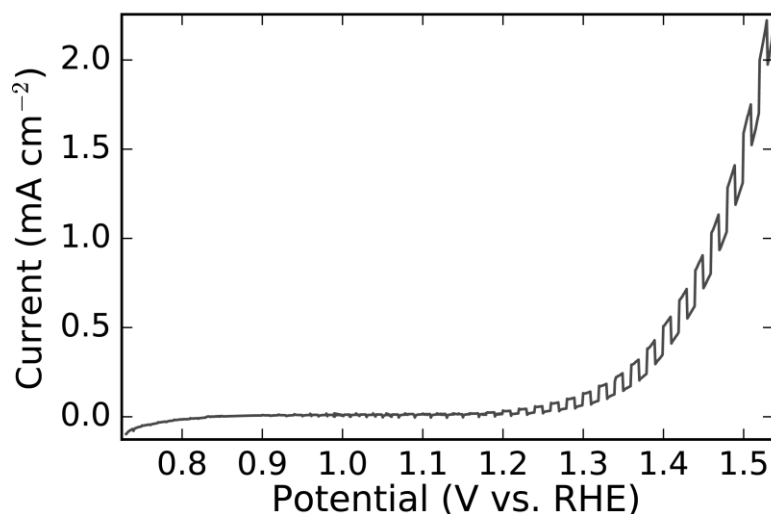


Figure S7. Linear sweep voltammogram at 0.02 V s^{-1} with toggled 385 nm illumination in pH 13 electrolyte with sodium sulfite hole scavenger on a $\text{Ni}_{0.64}\text{Mn}_{0.36}$ oxide, revealing photoactivity at 1.23 V vs RHE similar to that observed in Figure 2. The photocurrent increases dramatically with increased bias voltage, and the sulfite also oxidizes in the dark at potentials above 1.23 V vs RHE.

Computational details

DFT computations are performed using the Vienna software package (VASP)^{2,3} with the PAW pseudopotentials⁴, the generalized gradient approximation (GGA) as implemented by Perdew, Burke and Ernzerhoff (PBE)⁵, and the screened hybrid functional of Heyd, Scuseria, and Ernzerhof (HSE)⁶. We study the dependence of band gaps and band edge energies on the mixing parameter for the Hartree-Fock exchange potential which is in a range from 10% to 25%. We adopt a 6x6x6 Gamma-centered k-point mesh for the integrations over the Brillouin zone. Spin-polarization is included in all calculations with ferrimagnetic magnetic configurations for Mn atoms in NiMnO_3 and ferromagnetic orderings for those in Ni_6MnO_8 . The Hubbard U value for Mn and Ni used in the PBE+U surface slab calculations are adopted from the previous work.⁷ An energy cutoff of 450 eV is used for the HSE bulk calculations and PBE+U surface slab calculations.

Ni_6MnO_8 electronic structure and implications for heterojunction with NiMnO_3

As noted in the communication, an HSE mixing parameter of 14% provides quantitative agreement between the HSE and measured direct band gaps. To characterize the nature of the heterojunction described in the communication, HSE calculations with the same mixing parameter were performed on Ni_6MnO_8 . The full band structure was calculated using PBE+U and the results are summarized in Figure S8. The Ni_6MnO_8 VBM is at slightly higher energy than NiMnO_3 such that a heterojunction would involve hole injection from NiMnO_3 to Ni_6MnO_8 as illustrated in the figure. Since NiMnO_3 is pseudo-direct but Ni_6MnO_8 has a much lower CBM that defines its indirect gap, the nature of the junction appears to be sufficiently complicated that the exact mechanism for the improvement in photocurrent in the phase-mixed samples cannot be completely understood from these initial calculations.

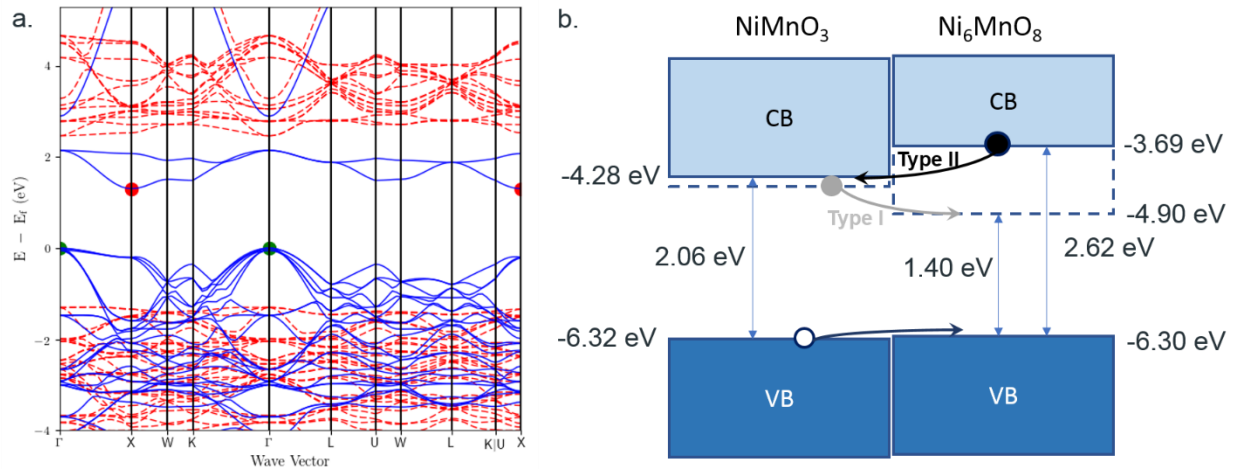


Figure S8. a. Calculated band diagram (PBE+U) for Ni_6MnO_8 with spin up and spin down channels denoted with red dashes and solid blue, respectively. The VBM and CBM are noted by green and red points, respectively. b. Band alignment from HSE calculations with 14% mixing parameter where band gaps are labelled with blue arrows and the other energies refer to band edges with respect to vacuum. The calculated Ni_6MnO_8 direct gap of 2.62 eV is similar to the measured direct gap of 2.4 eV. The calculated indirect gap of 1.40 eV, which has the same VBM as the indirect CBM illustrated with a dashed line, is closer to the lower of the 2 possible indirect band gap values inferred from the Tauc signal in Figure S3.

Structural details for NiMnO_3 and Ni_6MnO_8

The NiMnO_3 and Ni_6MnO_8 crystal structures are illustrated in Figure 3 and are space group 148 and 225, respectively. The lattice constants of relaxed models with the 14% mixing parameter are 0.5334 nm and 0.5919 nm, respectively, in good agreement with the ICSD values of 0.5343 and 0.5883, respectively. The calculated lattice angle of NiMnO_3 is 54.66° , which is also in excellent agreement with the experimental value of 54.65° . The angles for Ni_6MnO_8 is 60° by definition. The ICSD values are obtained from Materials Project, NiMnO_3 with mp-19331 and Ni_6MnO_8 with mp-19442.

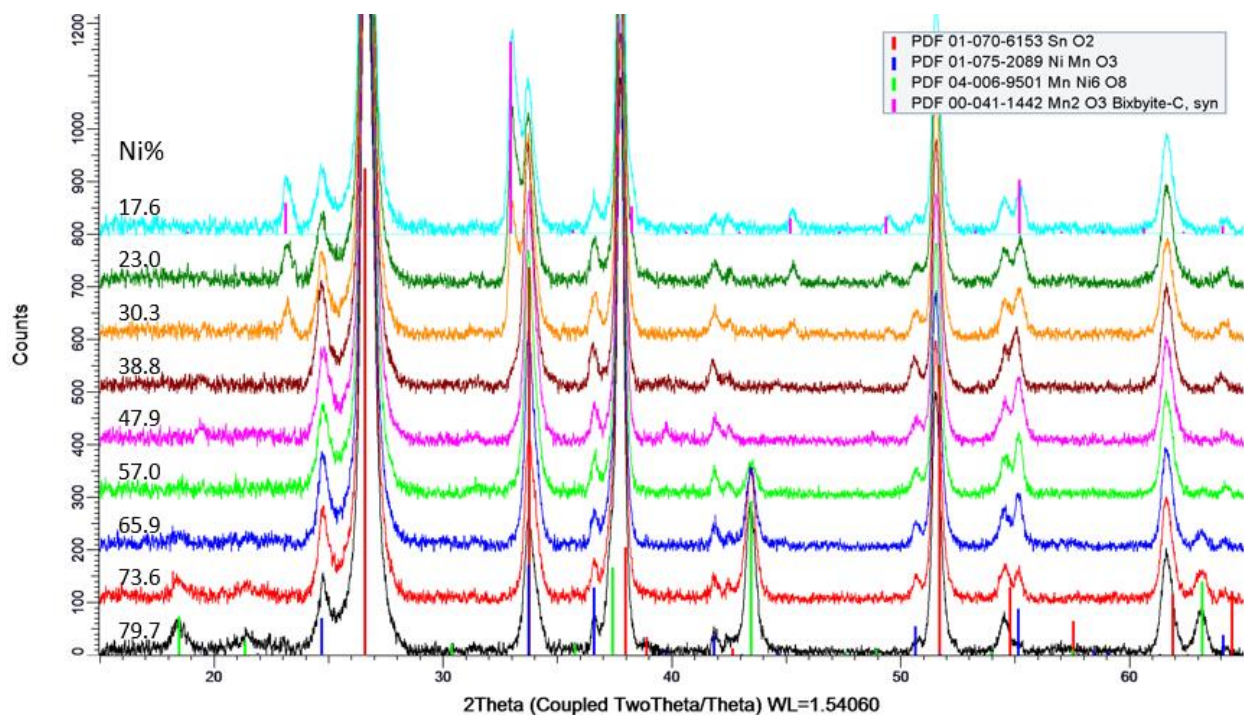


Figure S9. Integrated 1D XRD patterns along the thin film compositions, which were used to derive composition-dependent phase behavior shown in Figure 1c in the main text. Three phases were identified: Mn_2O_3 (ICDD PDF: 00-041-1442), NiMnO_3 (ICDD PDF: 01-075-2089) and Ni_6MnO_8 (04-006-9501). No differences were observed between the measured XRD pattern and ICDD stick patterns. With increasing Ni content, the phases were the mixture of Mn_2O_3 with NiMnO_3 to phase pure NiMnO_3 , and further became the mixture of Ni_6MnO_8 and NiMnO_3 . Since there is no evidence of any structural change of NiMnO_3 phase, the observed improvement of PEC performance is due to the mixed phases of Ni_6MnO_8 and NiMnO_3 .

The grain size of Ni_6MnO_8 and NiMnO_3 phases is approximately 17 nm and 21 nm, respectively. They were calculated using (400) diffraction peak at $2\theta=43.47^\circ$ for Ni_6MnO_8 and (110) peak at $2\theta=36.61^\circ$ for NiMnO_3 . Within the resolution of the measurement, no deviations were observed from either database peak pattern, indicating that the lattice constants and bond angles noted above are representative of these phases as they exist in the thin film photoanode samples.

Mott-Schottky analysis

Mott-Schottky analysis (MS-A) was carried out in the same pH 13 electrolyte as used in the other experiments. MS-A was performed using an o-ring sealed cell enclosing approximately 0.25 cm^2 of the thin film library in the phase-pure NiMnO_3 region. MS-A was done at a constant frequency of 5.5 kHz and 20 mV RMS between 1.1 to 1.8 V vs. RHE in 50 mV steps. Due to the imperfect nature of the coating two capacitors C1 and C2 were assumed to be in parallel to model a Faradaic and space charge contribution. From this MS-A the flatband is estimated to be between 1.1 and 1.2 V vs. RHE. The onset of photocurrent in Figure S7 is approximately 1.1 V vs RHE, in reasonable agreement with the MS-A result. Assuming the relative dielectric constant of NiMnO_3 between 5.7 (NiO^8) and 64 (MnO_2^9) the charge carrier density is on the order of 10^{13} to 10^{14} cm^{-3} , indicating that the semiconductor is not degeneratively doped. This flatband potential is far higher than desirable for solar photochemistry applications, and comparison with the band energy calculations of Figure 4 indicates that the Fermi level is closer to the VBM than CBM, counter to the standard picture of the band energetics of an n-type

semiconductor. Further study will be required to fully characterize band energetic in this material, and in particular whether there is a mid-gap state that is pinning the Fermi level and whose elimination would result in a major advance in the development of nickel manganates for solar photochemistry.

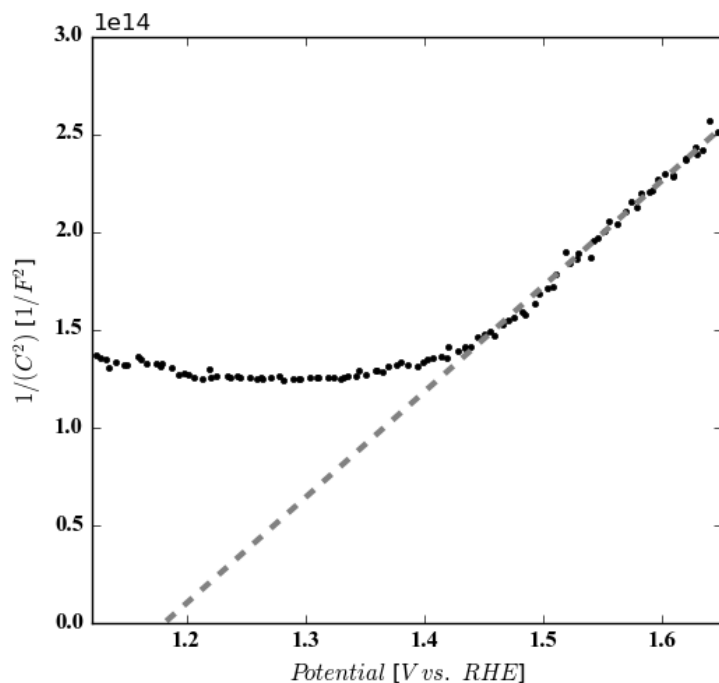


Figure S10. Mott-Schottky analysis assuming two parallel capacitor circuits. The material is n-type with a flatband potential of 1.1-1.2 V vs. RHE and a charge carrier density extracted from the slope Mott-Schottky slope indicated by the dashed grey line of 10^{13} to 10^{14} cm^{-3} .

References

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